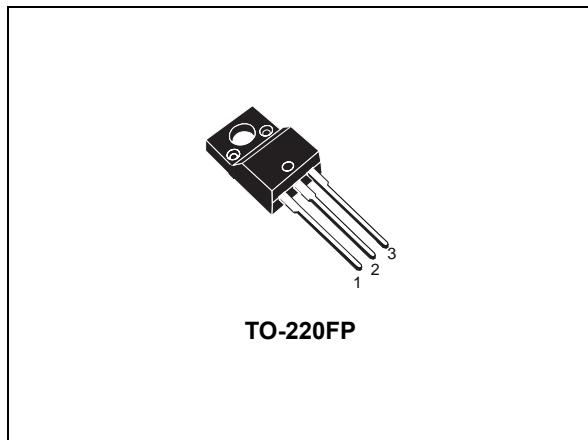
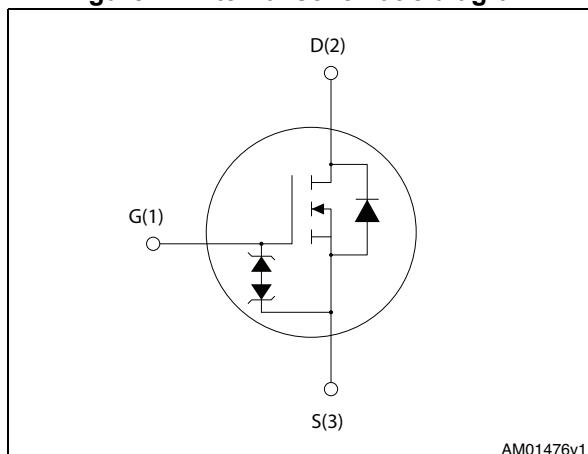


## N-channel 950 V, 1 $\Omega$ typ., 9 A MDmesh™ K5 Power MOSFET in a TO-220FP package

Datasheet - production data



**Figure 1. Internal schematic diagram**



## Features

Order code	V <sub>DS</sub>	R <sub>DS(on)</sub> max.	I <sub>D</sub>	P <sub>TOT</sub>
STF6N95K5	950 V	1.25 $\Omega$	9 A	25 W

- Industry's lowest R<sub>DS(on)</sub> \* area
- Industry's best figure of merit (FoM)
- Ultra-low gate charge
- 100% avalanche tested
- Zener-protected

## Applications

- Switching applications

## Description

This very high voltage N-channel Power MOSFET is designed using MDmesh™ K5 technology based on an innovative proprietary vertical structure. The result is a dramatic reduction in on-resistance and ultra-low gate charge for applications requiring superior power density and high efficiency.

**Table 1. Device summary**

Order code	Marking	Packages	Packaging
STF6N95K5	6N95K5	TO-220FP	Tube

## Contents

<b>1</b>	<b>Electrical ratings</b>	<b>3</b>
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# 1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
$V_{GS}$	Gate- source voltage	$\pm 30$	V
$I_D$	Drain current (continuous) at $T_C = 25^\circ\text{C}$	9 <sup>(1)</sup>	A
$I_D$	Drain current (continuous) at $T_C = 100^\circ\text{C}$	6 <sup>(1)</sup>	A
$I_{DM}^{(2)}$	Drain current (pulsed)	36	A
$P_{TOT}$	Total dissipation at $T_C = 25^\circ\text{C}$	25	W
$I_{AR}^{(3)}$	Max current during repetitive or single pulse avalanche	3	A
$E_{AS}$	Single pulse avalanche energy (starting $T_J = 25^\circ\text{C}$ , $I_D=I_{AS}$ , $V_{DD}= 50\text{ V}$ )	90	mJ
$V_{ISO}$	Insulation withstand voltage (RMS) from all three leads to external heat sink ( $t=1\text{ s}$ ; $T_C=25^\circ\text{C}$ )	2500	V
$dv/dt^{(4)}$	Peak diode recovery voltage slope	4.5	V/ns
$dv/dt^{(5)}$	MOSFET $dv/dt$ ruggedness	50	V/ns
$T_j$ $T_{stg}$	Operating junction temperature Storage temperature	- 55 to 150	°C

1. Limited by package.
2. Pulse width limited by safe operating area.
3. Pulse width limited by  $T_{Jmax}$ .
4.  $I_{SD} \leq 9\text{ A}$ ,  $dI/dt \leq 100\text{ A}/\mu\text{s}$ ,  $V_{DS(\text{peak})} \leq V_{(\text{BR})DSS}$
5.  $V_{DS} \leq 760\text{ V}$

Table 3. Thermal data

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal resistance junction-case max	5	°C/W
$R_{thj-amb}$	Thermal resistance junction-amb max	62.5	°C/W

## 2 Electrical characteristics

( $T_{CASE} = 25^\circ\text{C}$  unless otherwise specified)

**Table 4. On/off states**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS} = 0, I_D = 1 \text{ mA}$	950			V
$I_{DSS}$	Zero gate voltage drain current	$V_{GS} = 0, V_{DS} = 950 \text{ V}$			1	$\mu\text{A}$
		$V_{GS} = 0, V_{DS} = 950 \text{ V}, T_c = 125^\circ\text{C}$			50	$\mu\text{A}$
$I_{GSS}$	Gate body leakage current	$V_{DS} = 0, V_{GS} = \pm 20 \text{ V}$			$\pm 10$	$\mu\text{A}$
$V_{GS(\text{th})}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 100 \mu\text{A}$	3	4	5	V
$R_{DS(\text{on})}$	Static drain-source on-resistance	$V_{GS} = 10 \text{ V}, I_D = 3 \text{ A}$		1	1.25	$\Omega$

**Table 5. Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{iss}$	Input capacitance	$V_{GS} = 0, V_{DS} = 100 \text{ V}, f = 1 \text{ MHz}$	-	450	-	pF
$C_{oss}$	Output capacitance		-	30	-	pF
$C_{rss}$	Reverse transfer capacitance		-	1.6	-	pF
$C_{o(\text{tr})}^{(1)}$	Equivalent capacitance time related	$V_{GS} = 0, V_{DS} = 0 \text{ to } 760 \text{ V}$	-	45	-	pF
$C_{o(er)}^{(2)}$	Equivalent capacitance energy related		-	19	-	pF
$R_G$	Intrinsic gate resistance	$f = 1 \text{ MHz}, I_D = 0$	-	7	-	$\Omega$
$Q_g$	Total gate charge	$V_{DD} = 760 \text{ V}, I_D = 6 \text{ A}, V_{GS} = 10 \text{ V},$ (see <a href="#">Figure 16</a> )	-	13	-	nC
$Q_{gs}$	Gate-source charge		-	3	-	nC
$Q_{gd}$	Gate-drain charge		-	7	-	nC

1. Time related is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$
2. energy related is defined as a constant equivalent capacitance giving the same stored energy as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$

**Table 6. Switching times**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 475 \text{ V}$ , $I_D = 3 \text{ A}$ , $R_G = 4.7 \Omega$ , $V_{GS} = 10 \text{ V}$ (see <i>Figure 18</i> )	-	12	-	ns
$t_r$	Rise time		-	12	-	ns
$t_{d(off)}$	Turn-off delay time		-	33	-	ns
$t_f$	Fall time		-	21	-	ns

**Table 7. Source drain diode**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{SD}$	Source-drain current		-		9	A
$I_{SDM}$	Source-drain current (pulsed)		-		36	A
$V_{SD}^{(1)}$	Forward on voltage	$I_{SD} = 6 \text{ A}$ , $V_{GS} = 0$	-		1.6	V
$t_{rr}$	Reverse recovery time	$I_{SD} = 6 \text{ A}$ , $V_{DD} = 60 \text{ V}$ $di/dt = 100 \text{ A}/\mu\text{s}$ , (see <i>Figure 17</i> )	-	372		ns
$Q_{rr}$	Reverse recovery charge		-	4		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current		-	22		A
$t_{rr}$	Reverse recovery time	$I_{SD} = 6 \text{ A}$ , $V_{DD} = 60 \text{ V}$ $di/dt = 100 \text{ A}/\mu\text{s}$ , $T_j = 150^\circ\text{C}$ (see <i>Figure 17</i> )	-	522		ns
$Q_{rr}$	Reverse recovery charge		-	5		$\mu\text{C}$
$I_{RRM}$	Reverse recovery current		-	20		A

1. Pulsed: pulse duration = 300 $\mu\text{s}$ , duty cycle 1.5%

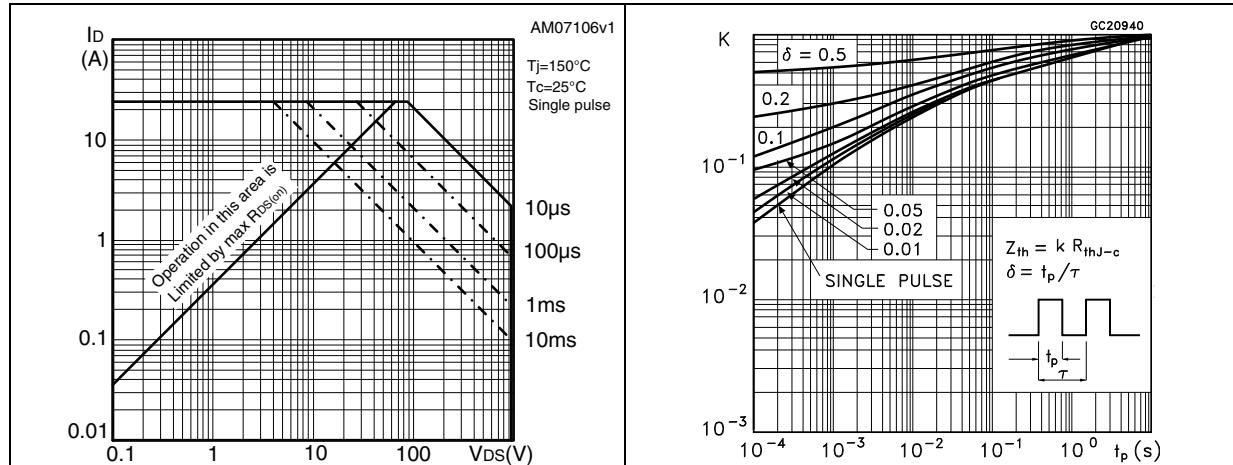
**Table 8. Gate-source Zener diode**

Symbol	Parameter	Test conditions	Min	Typ.	Max.	Unit
$V_{(BR)GSO}$	Gate-source breakdown voltage	$I_{GS} = \pm 1 \text{ mA}$ , $I_D = 0$	30	-	-	V

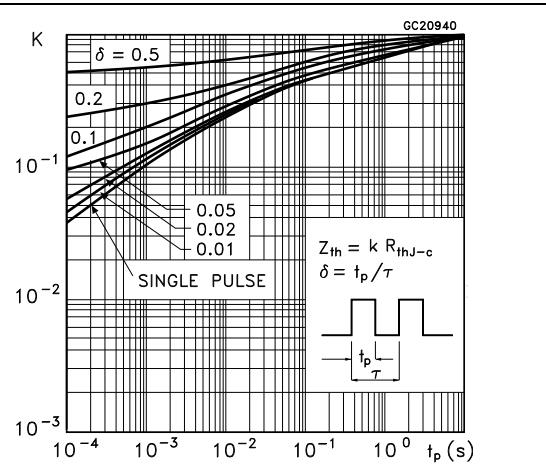
The built-in back-to-back Zener diodes have specifically been designed to enhance the device's ESD capability. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

## 2.1 Electrical characteristics (curves)

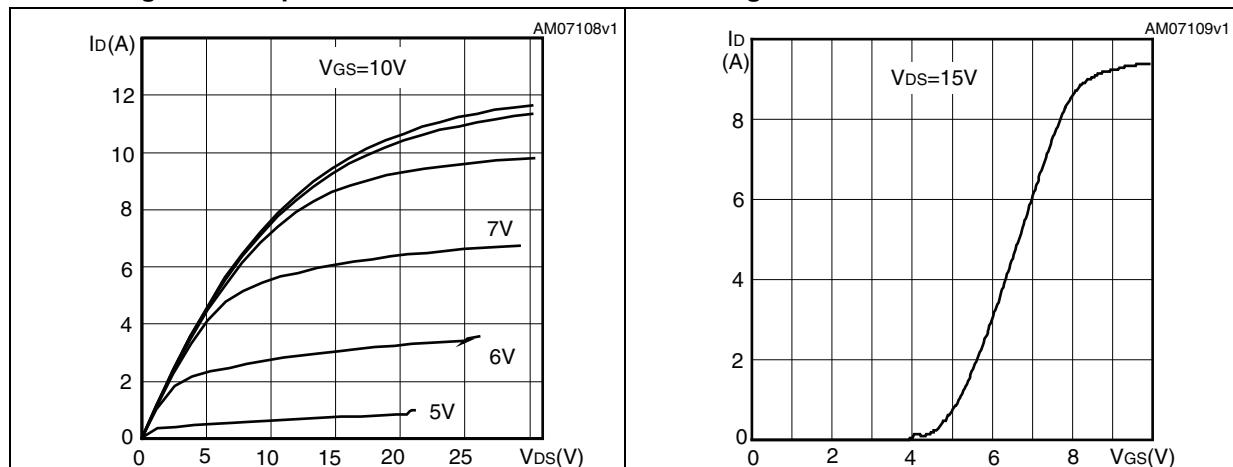
**Figure 2. Safe operating area**



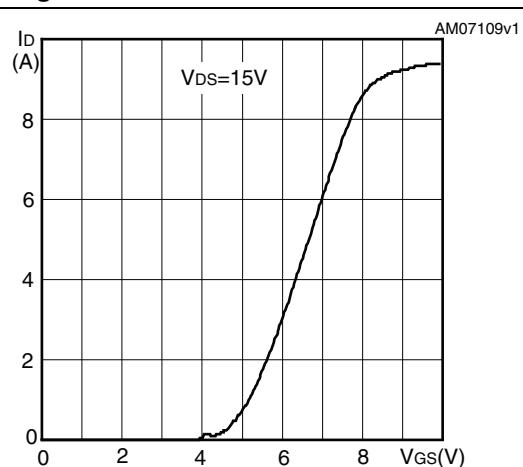
**Figure 3. Thermal impedance**



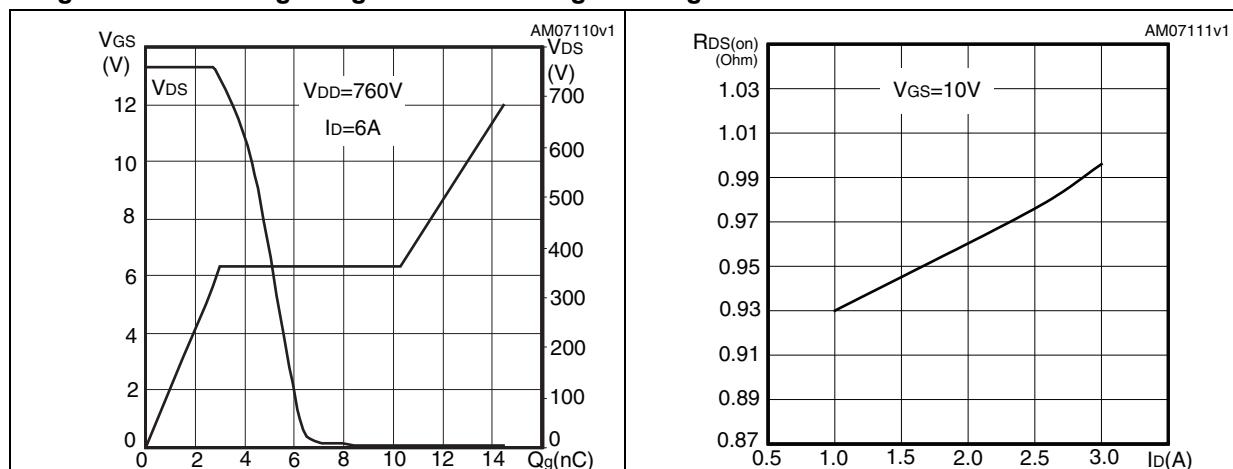
**Figure 4. Output characteristics**



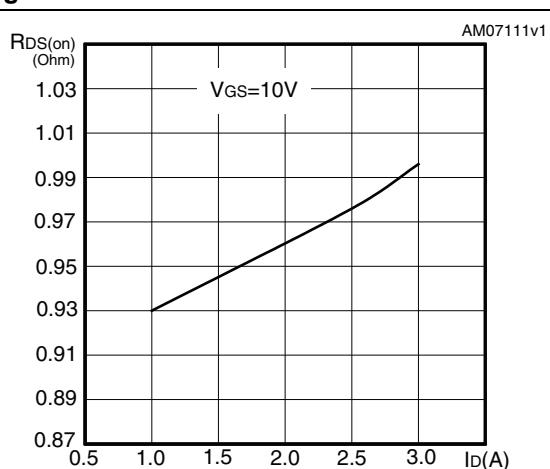
**Figure 5. Transfer characteristics**

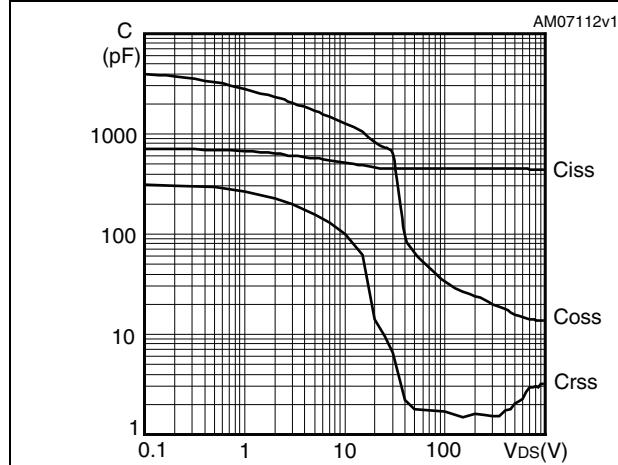
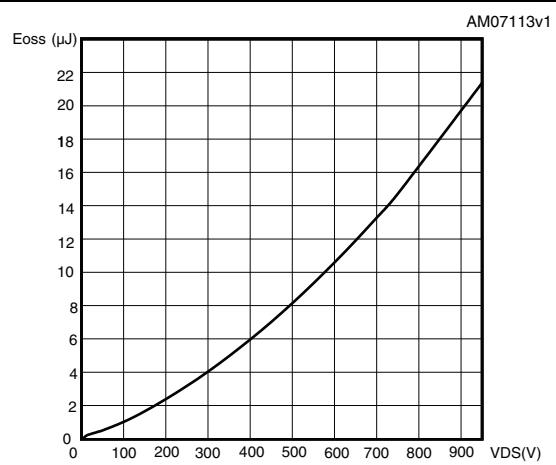
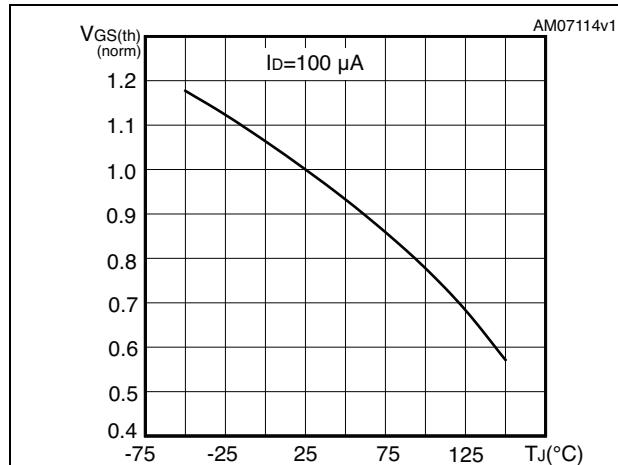
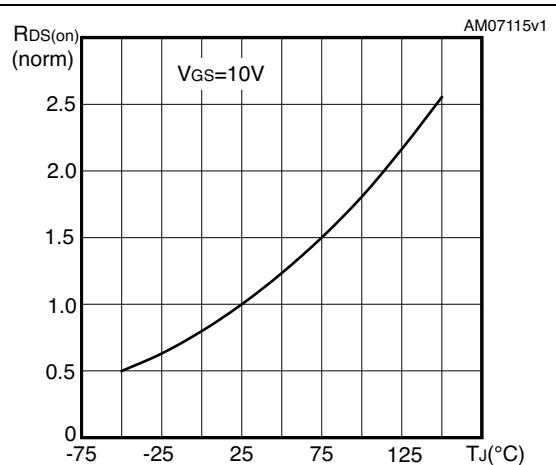
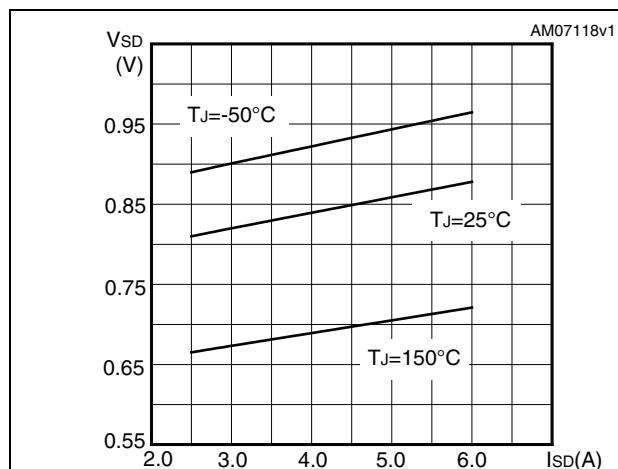
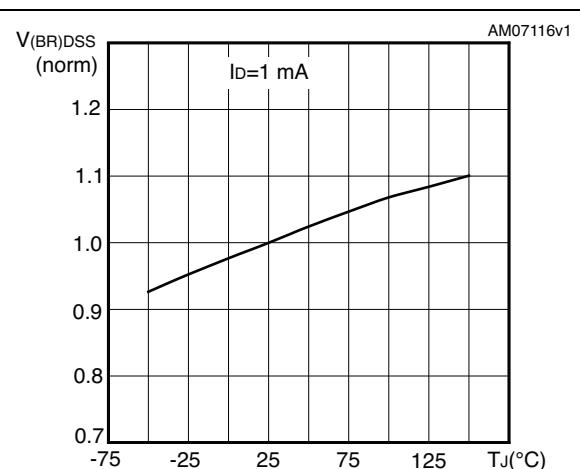


**Figure 6. Gate charge vs gate-source voltage**

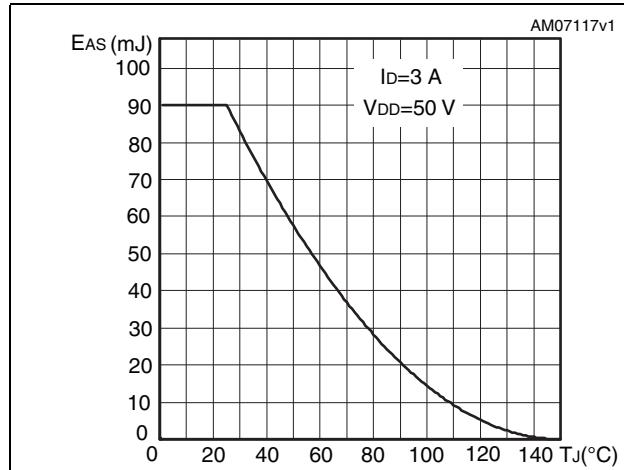


**Figure 7. Static drain-source on-resistance**



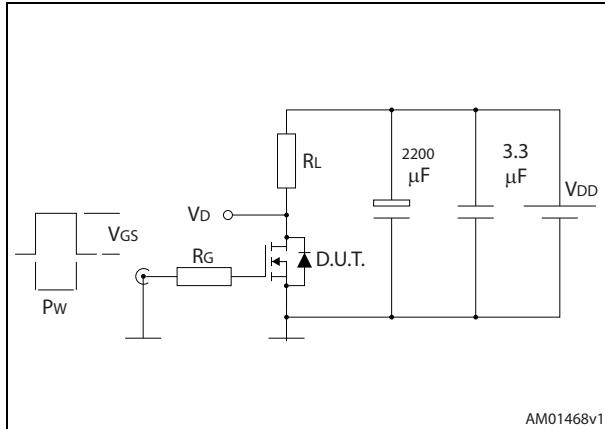
**Figure 8. Capacitance variations****Figure 9. Output capacitance stored energy****Figure 10. Normalized gate threshold voltage vs temperature****Figure 11. Normalized on-resistance vs temperature****Figure 12. Source-drain diode forward characteristics****Figure 13. Normalized V<sub>(BR)DSS</sub> vs temperature**

**Figure 14. Maximum avalanche energy vs starting  $T_j$**

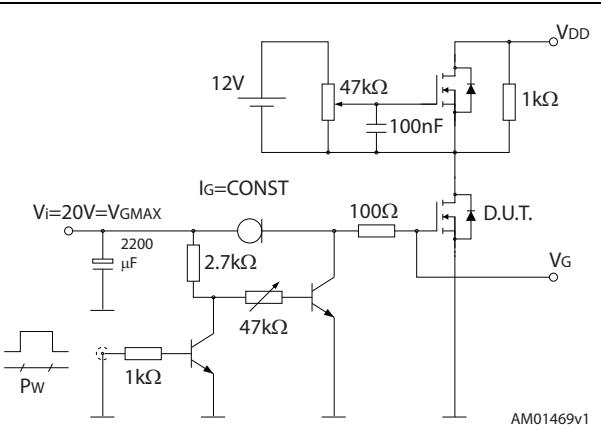


### 3 Test circuits

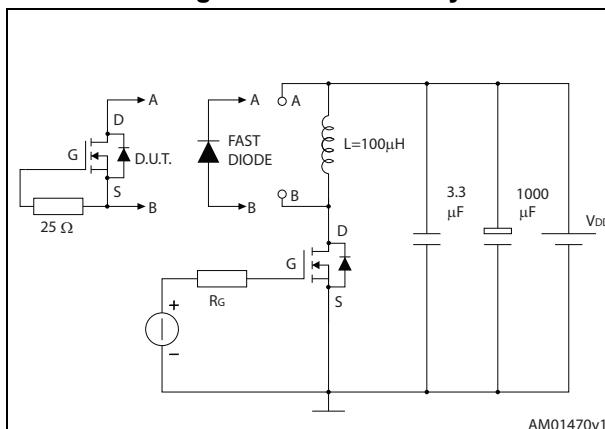
**Figure 15. Switching times test circuit for resistive load**



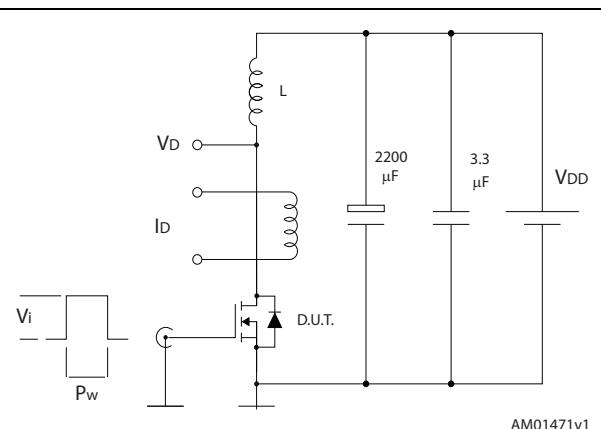
**Figure 16. Gate charge test circuit**



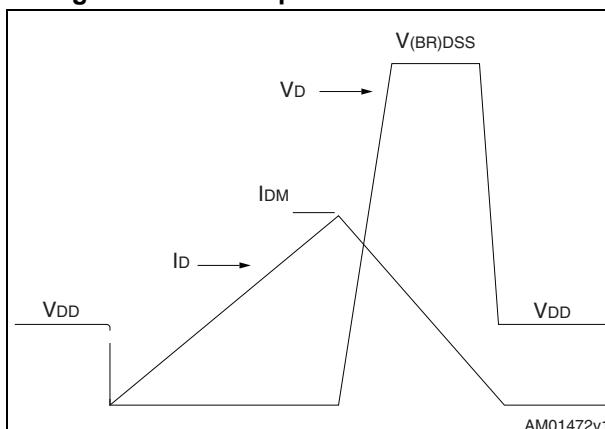
**Figure 17. Test circuit for inductive load switching and diode recovery times**



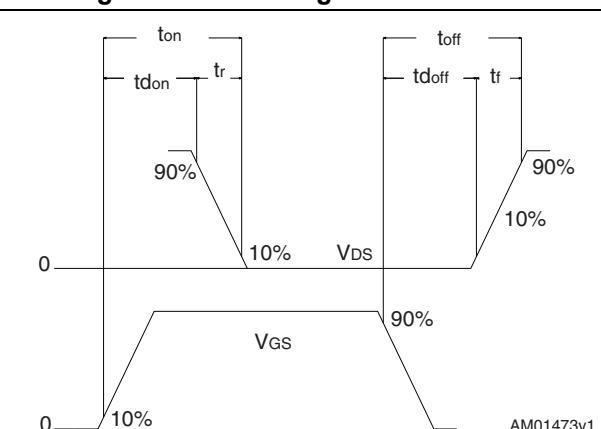
**Figure 18. Unclamped inductive load test circuit**



**Figure 19. Unclamped inductive waveform**



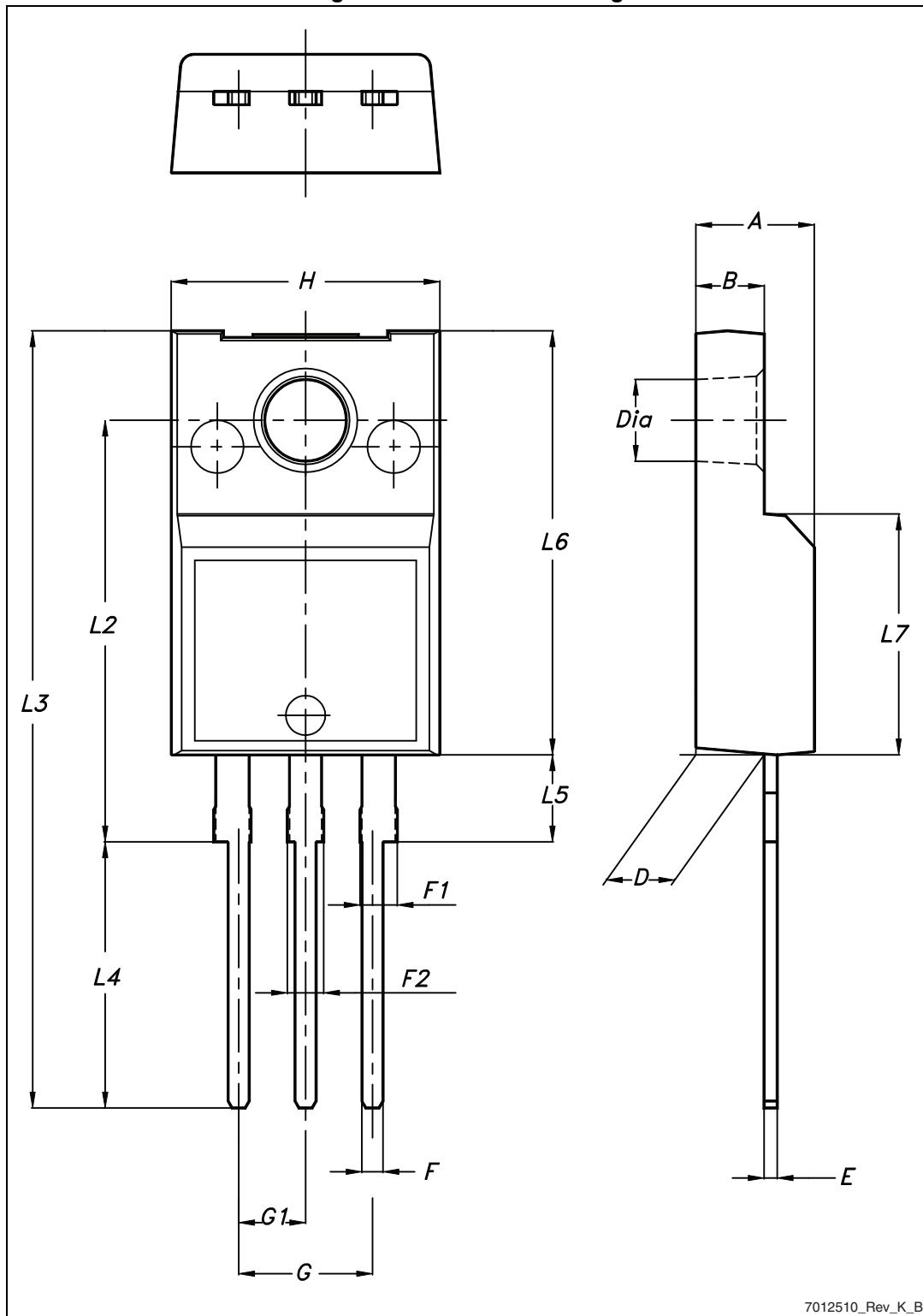
**Figure 20. Switching time waveform**



## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com).  
ECOPACK® is an ST trademark.

Figure 21. TO-220FP drawing



7012510\_Rev\_K\_B

**Table 9. TO-220FP mechanical data**

Dim.	mm		
	Min.	Typ.	Max.
A	4.4		4.6
B	2.5		2.7
D	2.5		2.75
E	0.45		0.7
F	0.75		1
F1	1.15		1.70
F2	1.15		1.70
G	4.95		5.2
G1	2.4		2.7
H	10		10.4
L2		16	
L3	28.6		30.6
L4	9.8		10.6
L5	2.9		3.6
L6	15.9		16.4
L7	9		9.3
Ø	3		3.2

## 5 Revision history

**Table 10. Document revision history**

Date	Revision	Changes
27-May-2014	1	First release. Part number previously included in datasheet DocID16958
03-Sep-2015	2	Updated <a href="#">Table 2.: Absolute maximum ratings</a> Minor text changes.

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